SGS-THOMSON MICROELECTRONICS

BTA 04 GP

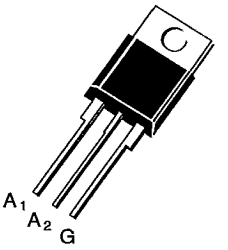
S G S-THOMSON

TRIACS

- GLASS PASSIVATED CHIP
- I_{GT} SPECIFIED IN FOUR QUADRANTS
- INSULATING VOLTAGE : 2500 V_{RMS}
- UL RECOGNIZED (E81734)

ADVANTAGES

- $I_H < 13$ mA
- HIGH SURGE CURRENT : $I_{TSM} = 50$ A



TO 220 AB
(Plastic)

DESCRIPTION

Insulated triacs specified for light dimmer applications.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
$I_{T(RMS)}$	RMS on-state Current (360° conduction angle)	$T_C = 75$ °C	4	A
I_{TSM}	Non Repetitive Surge Peak on-state Current (T_j initial = 25 °C - Half sine wave)	t = 8.3 ms	52	A
		t = 10 ms	50	
I^2t	I^2t Value for Fusing	t = 10 ms	12.5	A^2s
di/dt	Critical Rate of Rise of on-state Current (1)	Repetitive F = 50 Hz	10	A/µs
		Non Repetitive	50	
T_{stg} T_j	Storage and Operating Junction Temperature Range		– 40 to 125 – 40 to 110	°C °C

Symbol	Parameter	BTA 04–			Unit
		200GP	400GP	600GP	
V_{DRM}	Repetitive Peak off-state Voltage (2)	200	400	600	V

(1) $I_G = 750$ mA $dI_G/dt = 1$ A/µs
(2) $T_j = 110$ °C.

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th\ (j-a)}$	Junction to Ambient	60	°C/W
$R_{th\ (j-c)}$ DC	Junction to Case for DC	8.7	°C/W
$R_{th\ (j-c)}$ AC	Junction to Case for 360° Conduction Angle (F = 50 Hz)	6.5	°C/W

GATE CHARACTERISTICS (maximum values)

P_{GM} = 40 W (t_p = 10 µs) I_{GM} = 4 A (t_p = 10 µs)
$P_{G(AV)}$ = 1 W V_{GM} = 16 V (t_p = 10 µs)

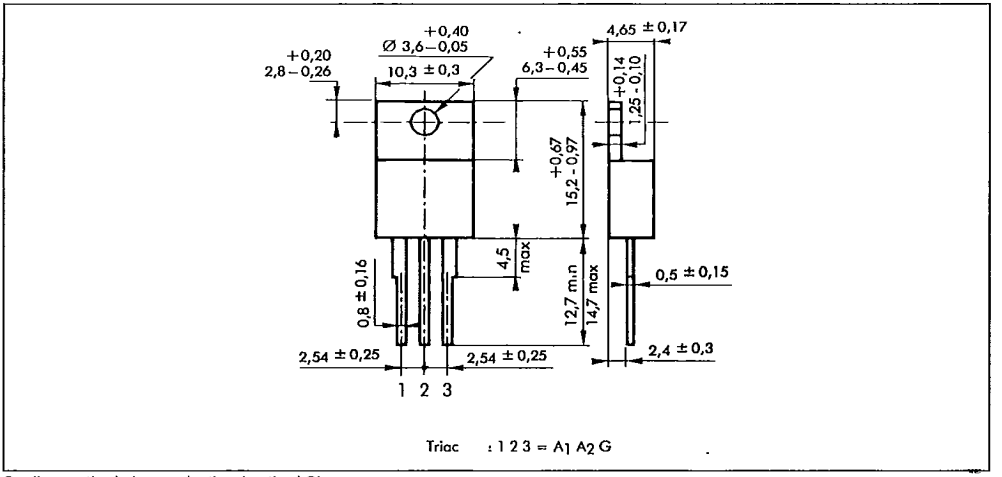
ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions			Quadrants	Min.	Typ.	Max.	Unit
I_{GT}	T_j = 25 °C V_D = 12 V R_L = 33 Ω Pulse Duration > 20 µs			I-II-III		15	50	mA
				IV		25	75	
V_{GT}	T_j = 25 °C V_D = 12 V R_L = 33 Ω Pulse Duration > 20 µs			I-II-III-IV			1.5	V
V_{GD}	T_j = 110 °C V_D = V_{DRM}		R_L = 3.3 kΩ	I-II-III-IV	0.2			V
I_H*	T_j = 25 °C I_T = 100 mA		Gate Open				13	mA
I_L	T_j = 25 °C V_D = 12 V I_G = 150 mA Pulse Duration > 20 µs			I-III-IV		25		mA
				II		50		
V_{TM}*	T_j = 25 °C I_{TM} = 5.5 A		t_p = 10 ms				1.65	V
I_{DRM}*	V_{DRM} Specified		T_j = 25 °C				0.01	mA
			T_j = 110 °C				0.5	
dv/dt*	T_j = 110 °C Gate Open Linear Slope up to V_D = 67 % V_{DRM}				10			V/µs
$(dv/dt)_c$*	T_C = 75 °C V_D = V_{DRM} I_T = 5.5 A $(di/dt)_c$ = 1.8 A/ms					1		V/µs
t_{gt}	T_j = 25 °C V_D = V_{DRM} I_T = 5.5 A I_G = 100 mA di_G/dt = 1 A/µs			I-II-III-IV		2		µs

* For either polarity of electrode A_2 voltage with reference to electrode A_1.

PACKAGE MECHANICAL DATA

TO 220 AB Plastic



Cooling method : by conduction (method C)
Marking : type number
Weight : 2 g.

T-25-13

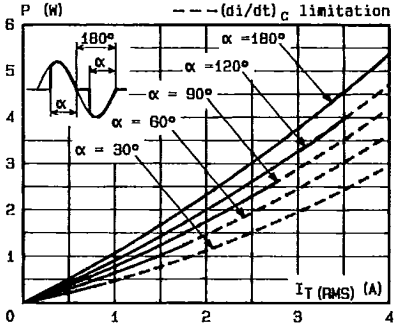


Fig.1 - Maximum mean power dissipation versus RMS on-state current (F = 60 Hz).

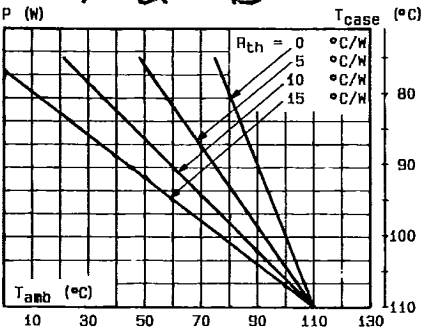


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

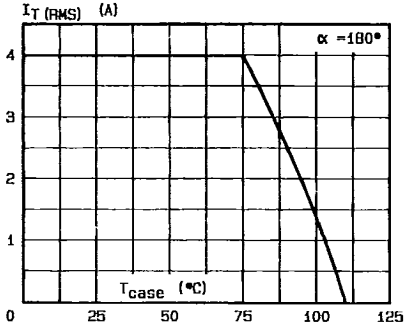


Fig.3 - RMS on-state current versus case temperature.

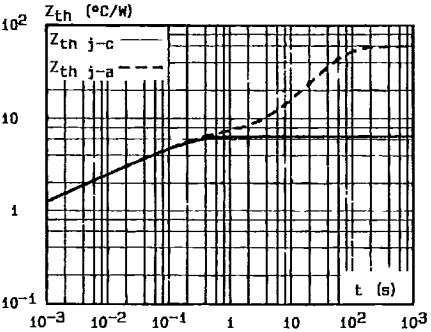


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

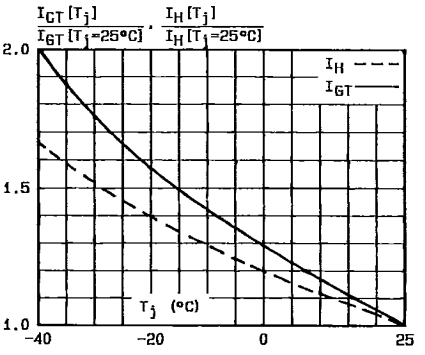


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

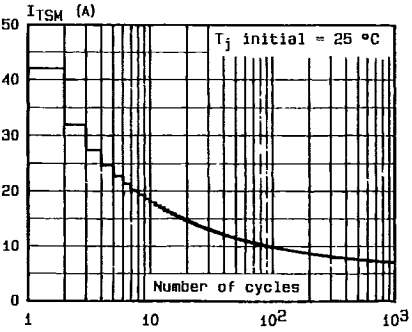


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.

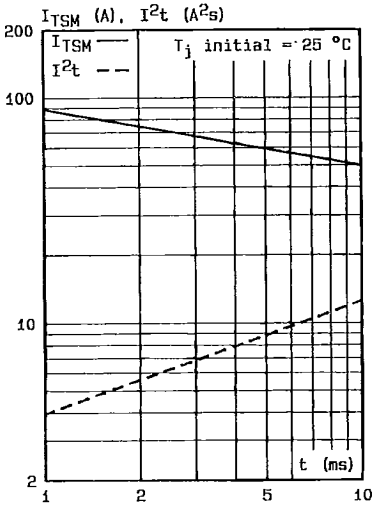


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : t ≤ 10 ms, and corresponding value of I^2t.

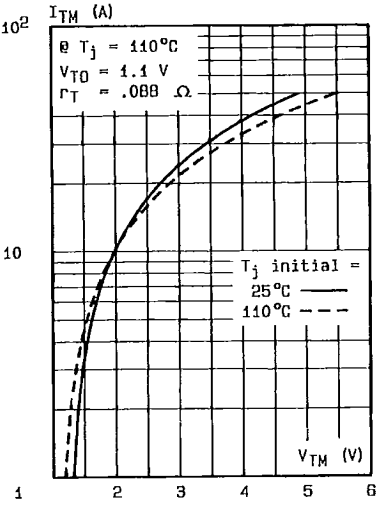


Fig.8 - On-state characteristics (maximum values).